



Notice of References Cited

Application/Control No.

10/008,591

Applicant(s)/Patent Under
Reexamination
DERSHEM ET AL.

Examiner

Richard L. Raymond

Art Unit

1624

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-			
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Richard L. Raymond

11/05

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